

APPLICATION NO.
New National Stage of
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APPLICANTS
Zemin SHI et al.

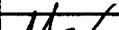


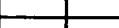


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U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
	1.	JP-A-2002-214610	07/31/2002	Japan	X	X
	2.	JP-A-2000-098134	04/07/2000	Japan	X	X
	3.	JP-A-2003-251643	09/09/2003	Japan	X	X
	4.	JP-A-2001-055573	02/27/2001	Japan	X	X
	5.	JP-A-2002-148600	05/22/2002	Japan	X	X
	6.	JP-A-2003-227935	08/15/2003	Japan	X	X

OTHER DOCUMENTS

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